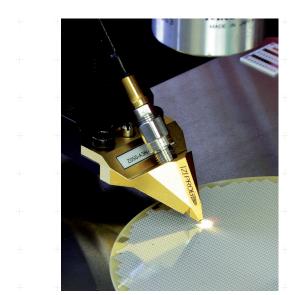
Cascade Microtech, Inc.

SPECIFICATION SHEET



Maximum performance up to 50 GHz

ZPROBE®

High-Frequency Wafer Probe (50 GHz)

For wafer-level test of RF and microwave devices, there is no better solution than Cascade Microtech's |Z| Probe. The patented technology used in the |Z| Probe assures high-accuracy measurements with low contact resistance and superior impedance control. The RF/microwave signal makes only one transition to the coplanar contact structure within the shielded, air-isolated probe body. This maintains the signal integrity with stable performance over a wide temperature range.

With the revolutionary 1MX™ technology, the |Z| Probe 50 GHz provides superior electrical performance, especially insertion and return loss. In addition, isolation (crosstalk) has been significantly improved resulting in a probe that delivers the highest accuracy for your wafer-level RF and microwave measurements.

Contacting the device under test (DUT) with the |Z| Probe is simple, highly repeatable and requires minimum overtravel. Additionally, the contacts can move independent of each other, allowing you to probe on three-dimensional structures and on wafers with padheight deviation of up to 50 μ m.

Used in conjunction with Cascade Microtech's HF probing system including ProbeHeads TM , powerful SussCal® Calibration Software and highly-accurate CSR family of calibration substrates, the |Z| Probe becomes the ultimate tool for all your HF wafer-level probing needs.

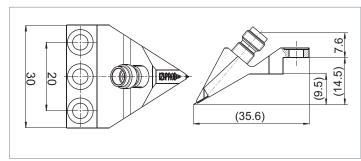
Thanks to the proven |Z| Probe technology, the probe also has an extremely long lifetime. It guarantees a useful life of at least 1,000,000 contact cycles under standard use and overtravel.

Durability	Incredibly long lifetime
	Unparalleled repeatable and reliable contact quality
	Suitable for automated testing
Flexibility	Probe on most pad material with minimal damage
	Independent, long contact springs easily overcome pad height differences up to 50 μm
	Small structures such as 40 µm x 40 µm pads can be tested
	Excellent performance in vacuum environments and temperatures from 10 K to 300°C
RF performance	Low contact resistance
	New 1MX technology ensures low insertion loss, high isolation and accurate measurements

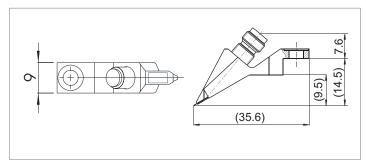
SPECIFICATIONS* Electrical Characteristics 50 Ω Characteristic impedance DC to 50 GHz Frequency range Return loss > 17 dB DC to 50 GHz** Insertion loss < 0.8 dB DC to 50 GHz** Maximum RF power 5 W at 50 GHz Maximum DC current 1.5 A 100 V Maximum DC voltage Contact resistance on Au $< 4 m\Omega^{**}$ **Mechanical Characteristics** Contacts Solid nickel springs Insulator RF dielectric Contact cycles on Al > 1,000,000 Contact spring pressure 6 N/mm Available standard pitches $50~\mu m$ to $200~\mu m$ with $25~\mu m$ increments, $200~\mu m$ to $500~\mu m$ with $50~\mu m$ increments **RF Connector** PC 2.4 mm, female Туре Coupling torque 0.8 Nm to 1.1 Nm (Recommended) Outer contact Stainless steel Center contact CuBe with Au plating Insulator PEEK **Environmental Data** Temperature range -100 °C to 200 °C (Type A and V, standard), 10 K to 300 °C (Type B and C, extreme temperature)

Not all specifications may be valid simultaneously.

PHYSICAL DIMENSIONS



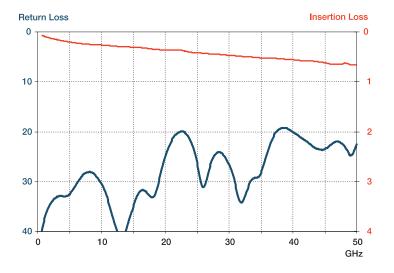
|Z| Probe standard case (all dimensions in mm).

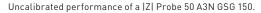


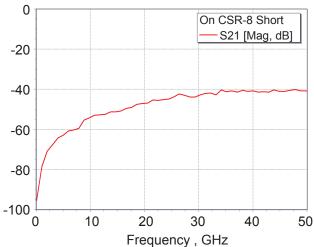
|Z| Probe slim case (all dimensions in mm).

^{*}Data, design and specification depend on individual process conditions and can vary according to equipment configurations.

^{**}Typical for probes with pitches from 50 μm to 200 μm

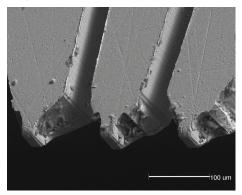




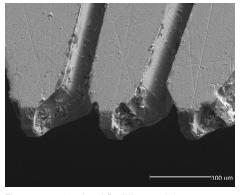


Signal isolation (crosstalk) of two |Z| Probes separated by a distance of 150 μm .

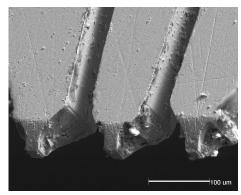
Long lifetime of |Z| Probe (Contact material: Al Overtravel: 75 µm)



New |Z| Probe (upside-down).



The same probe after 1.5 million touchdowns.



The same probe after three million touchdowns.

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Data subject to change without notice

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